

Search Notes

Application/Control No.

10/718,320

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DuyVu n. Deo

Applicant(s)/Patent under
Reexamination

CHAO ET AL.

Art Unit

1765

SEARCHED

Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED

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**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

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East: key words, class/sub (438/635-640,714,717,723-725)	11/15/2005	